

Search Notes

Application/Control No.

10/041,849

Examiner

Patrick H. Mackey

Applicant(s)/Patent under
Reexamination

TENG ET AL.

Art Unit

3651

SEARCHED

Class	Subclass	Date	Examiner
414	403 416.01 618		
	729 749.3		
	416.03		
	416.08		
901	3-5 9 46-47		
250	559.33		
414	937		
700	218 257	2/11/2005	PHM
Above	Updated	6/24/2005	PHM
Above	Updated	1/6/2006	PHM

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Text Search (USPAT, JPO, EPO)	1/6/2006	PHM